

Application/Control No.	Applicant(s)/Patent under Reexamination
09/625,664	HUNG ET AL.
Examiner	Art Unit
Soon D. Hyun	2663

SEARCHED					
Class	Subclass	Date	Examiner		
370 7	38 9 394 412-418 46 (-	5-11-05	5.		
/	46	V	V		
					

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
1					
		Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		